

Notice of References Cited	Application/Control No. 10/559,384	Applicant(s)/Patent Under Reexamination ALBECK ET AL.	
	Examiner SHEELA C. CHAWAN	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	XP000466818: Sansoni, G., et al., "A Novel, Adaptive System for 3-D Optical Profilometry Using A Liquid Crystal Light Projector", IEEE TRANSACTION ON INSTRUMENTATION AND MEASUREMENT, IEEE INC., Vol. 43, AO No. 4, pages 558-565, (1994).
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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